

<b>Notice of References Cited</b>		Application/Control No. 10/552,668	Applicant(s)/Patent Under Reexamination IKEMATSU ET AL.	
		Examiner John J. Zimmerman	Art Unit 1794	Page 1 of 1

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*	B	US-6,913,658 B2	07-2005	Delaunay et al.	148/625
*	C	US-2006/0124907 A1	06-2006	Takada et al.	252/500
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	M	US-			

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	N	JP 2001-279412	10-2001	Japan	Honda et al.	---
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**NON-PATENT DOCUMENTS**

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	U	English machine translation of JP 10-204580 (8-1998).
	V	English machine translation of JP 2000-290730 (10-2000).
	W	English machine translation of JP 2001-323355 (11-2001).
	X	English machine translation of JP 2002-173756 (6-2002).

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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